

<b>Notice of References Cited</b>	Application/Control No. 10/579,250		Applicant(s)/Patent Under Reexamination JEON ET AL.	
	Examiner WILLIAM K. CHEUNG		Art Unit 1796	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,980,395	12-1990	Mathur et al.	523/200
*	B	US-5,912,277	06-1999	Detterman, Robert Edwin	521/92
	C	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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